

Search Notes**Application/Control No.**

10/564,545

Examiner

LAN VINH

**Applicant(s)/Patent under
Reexamination**

SPITZ ET AL.

Art Unit

1713

SEARCHED

Class	Subclass	Date	Examiner
216	2,17,18,27 ,39	9/23/2010	LV
156	345.17	9/23/2010	LV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
216	2,17	9/23/2010	LV
156	345.17	9/23/2010	LV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
interference search and updating search in EAST, inventor search	9/23/2010	LV